

Notice of References Cited

Application/Control No.

10/598,631

Applicant(s)/Patent Under
Reexamination
YI ET AL.

Examiner

DIANA J. LIAO

Art Unit

1793

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0175408	11-2002	Majumdar et al.	257/734
*	B	US-6,465,088	10-2002	Talpaert et al.	428/307.3
*	C	US-2003/0148881	08-2003	Matsuo et al.	502/304
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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	T					

NON-PATENT DOCUMENTS

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